## **STN3N45K3**



# N-channel 450 V - 3.3 Ω typ., 0.6 A Zener-protected, SuperMESH3™ Power MOSFET in a SOT-223 package

Datasheet - production data

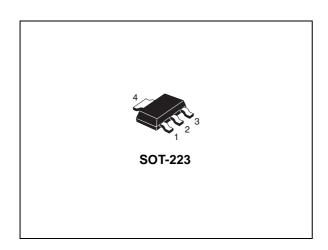
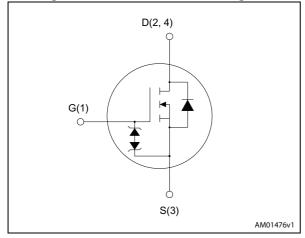


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	P <sub>w</sub>
STN3N45K3	450 V	< 4 Ω	0.6 A	3 W

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitance
- Improved diode reverse recovery characteristics
- Zener-protected

#### **Applications**

· Switching applications

#### **Description**

This SuperMESH3™ Power MOSFET is the result of improvements applied to STMicroelectronics' SuperMESH™ technology, combined with a new optimized vertical structure. This device boasts an extremely low onresistance, superior dynamic performance and high avalanche capability, rendering it suitable for the most demanding applications.

Table 1. Device summary

Order code	Marking	Package	Packaging
STN3N45K3	3N45K3	SOT-223	Tape and reel

Contents STN3N45K3

## **Contents**

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STN3N45K3 Electrical ratings

## 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	450	V
V <sub>GS</sub>	Gate- source voltage	± 30	V
I <sub>D</sub>	Drain current (continuous) at T <sub>amb</sub> = 25 °C	0.6	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	2.4	Α
P <sub>TOT</sub>	Total dissipation at T <sub>amb</sub> = 25 °C	3	W
I <sub>AR</sub> (2)	Avalanche current, repetitive or not-repetitive	0.6	Α
E <sub>AS</sub> (3)	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V)	45	mJ
dv/dt (4)	Peak diode recovery voltage slope	12	V/ns
Vesd(g-s)	G-S ESD (HBM C = 100 pF, R = 1.5 k $\Omega$ )	1000	V
T <sub>stg</sub>	Storage temperature	-55 to 150	°C
Tj	Max. operating junction temperature	150	°C

<sup>1.</sup> Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-a</sub> <sup>(1)</sup>	Thermal resistance junction-ambient	37.8	°C/W

<sup>1.</sup> When mounted on FR-4 board of 1 inch<sup>2</sup>, 2oz Cu, t < 30 sec

<sup>2.</sup> Pulse width limited by Tj max.

<sup>3.</sup> Starting Tj = 25 °C,  $I_D = I_{AR}$ ,  $V_{DD} = 50 \text{ V}$ .

<sup>4.</sup>  $I_{SD} \leq 0.6 \text{ A}, \text{ di/dt } \leq 400 \text{ A/}\mu\text{s}, V_{DS} \text{ peak } \leq V_{(BR)DSS}, V_{DD} = 80\% \text{ } V_{(BR)DSS}.$ 

Electrical characteristics STN3N45K3

## 2 Electrical characteristics

(T<sub>C</sub> = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$ Drain-source breakdown voltage $I_D = 1$		I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	450			V
		V <sub>DS</sub> = 450 V V <sub>DS</sub> = 450 V, T <sub>C</sub> =125 °C			1 50	μA μA
I <sub>GSS</sub> Gate-body leakage current (V <sub>DS</sub> = 0)		V <sub>GS</sub> = ± 20 V			± 10	μΑ
V <sub>GS(th)</sub> Gate threshold voltage		$V_{DS} = V_{GS}$ , $I_D = 50 \mu A$	3	3.75	4.5	V
Static drain-source on		$V_{GS} = 10 \text{ V}, I_D = 0.6 \text{ A}$		3.3	4	Ω

Table 5. Dynamic

Symbol	Parameter	Parameter Test conditions		Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	164	-	pF
C <sub>oss</sub>	Output capacitance	$V_{DS} = 50 \text{ V, f} = 1 \text{ MHz, V}_{GS} = 0$	-	17	-	pF
C <sub>rss</sub>	Reverse transfer capacitance		-	3	-	pF
C <sub>o(tr)</sub> <sup>(1)</sup>	Equivalent capacitance time related	$V_{DS} = 0$ to 360 V, $V_{GS} = 0$	-	13	-	pF
C <sub>o(er)</sub> <sup>(2)</sup>	Equivalent capacitance energy related	1 V <sub>DS</sub> = 0 to 360 V, V <sub>GS</sub> = 0	-	18	-	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz open drain	-	8	-	Ω
Qg	Total gate charge	V <sub>DD</sub> = 360 V, I <sub>D</sub> = 1.8 A,	-	9.5	-	nC
$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 10 V	-	2	-	nC
$Q_{gd}$	Gate-drain charge	(see Figure 16)	-	6	-	nC

<sup>1.</sup>  $C_{oss\,eq.}$  time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

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<sup>2.</sup>  $C_{oss\ eq.}$  energy related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

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Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t <sub>d(on)</sub>	Turn-on delay time		-	6.5	-	ns
t <sub>r</sub>	Rise time	$V_{DD} = 225 \text{ V}, I_D = 0.9 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	5.4	-	ns
t <sub>d(off)</sub>	Turn-off-delay time	(see <i>Figure 15</i> )	-	17	-	ns

Table 6. Switching times

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		0.6	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		2.4	Α
V <sub>SD</sub> (2)	Forward on voltage	$I_{SD} = 0.6 \text{ A}, V_{GS} = 0$	-		1.5	V
t <sub>rr</sub>	Reverse recovery time	1 0 0 1 1/1 100 0/	-	175		ns
Q <sub>rr</sub>	Reverse recovery charge	I <sub>SD</sub> = 1.8 A, di/dt = 100 A/μs V <sub>DD</sub> = 60 V (see <i>Figure 20</i> )	-	550		nC
I <sub>RRM</sub>	Reverse recovery current	1 1 <sub>00</sub> = 33 1 (333 1 igal 2 2 )	-	6		Α
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 1.8 A, di/dt = 100 A/µs	-	185		ns
Q <sub>rr</sub>	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 ^{\circ}\text{C}$	-	600		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 20)	-	6.5		Α

<sup>1.</sup> Pulse width limited by safe operating area.

Fall time

 $t_f$ 

Table 8. Gate-source Zener diode

Syn	nbol	Parameter	Test conditions	Min	Тур	Max	Unit
V <sub>(BR</sub>	R)GSO	Gate-source breakdown voltage	$I_{GS}$ = ± 1 mA, $I_{D}$ =0	30	-	-	V

The built-in back-to-back Zener diodes have been specifically designed to enhance not only the device's ESD capability, but also to make them capable of safely absorbing any voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve efficient and cost-effective protection of device integrity. The integrated Zener diodes thus eliminate the need for external components.

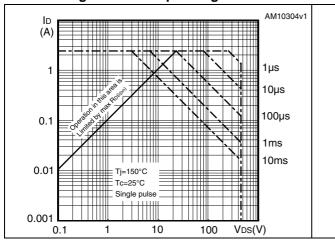
<sup>2.</sup> Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%.

Electrical characteristics STN3N45K3

#### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance



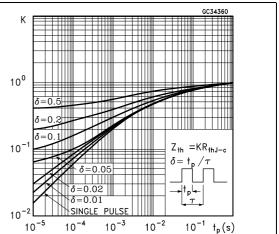
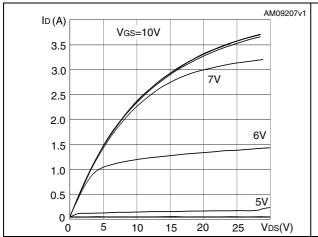


Figure 4. Output characteristics

Figure 5. Transfer characteristics



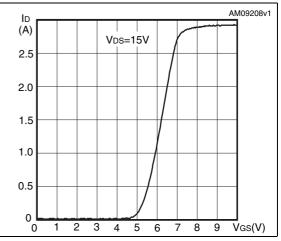
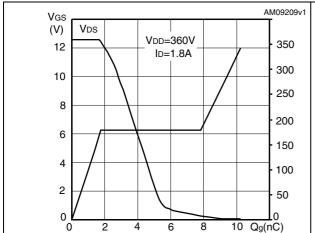
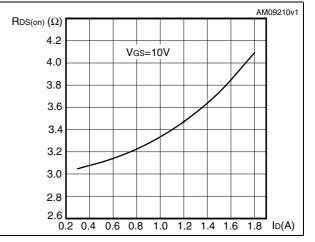


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on resistance





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Figure 8. Capacitance variations

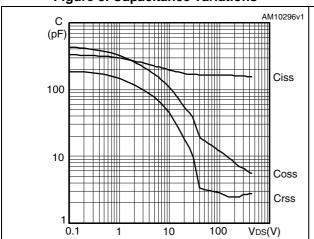


Figure 9. Output capacitance stored energy

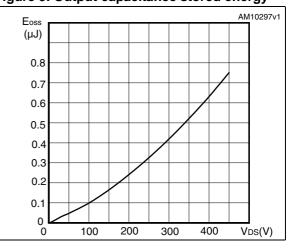
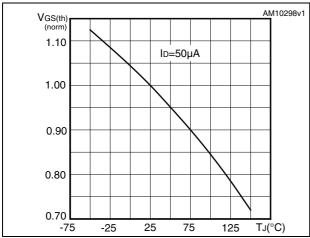


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



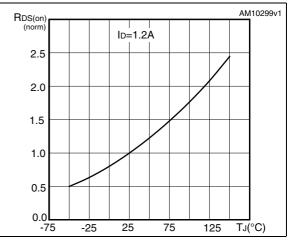
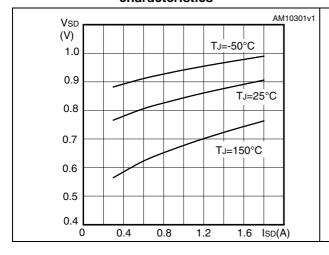
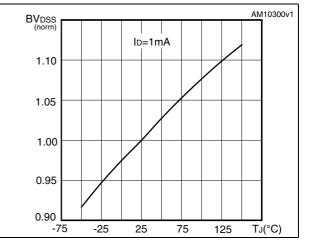


Figure 12. Source-drain diode forward characteristics

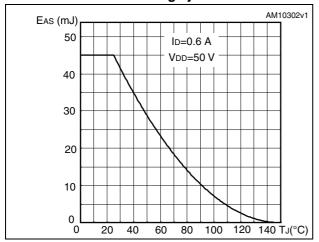
Figure 13. Normalized B<sub>VDSS</sub> vs temperature





Electrical characteristics STN3N45K3

Figure 14. Maximum avalanche energy vs starting Tj



STN3N45K3 Test circuits

#### 3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

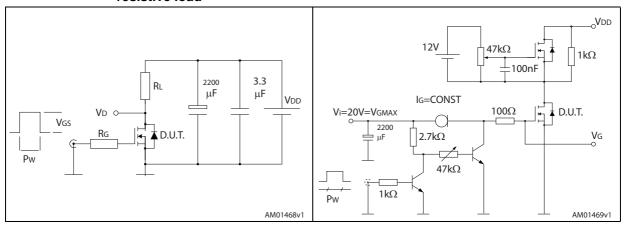


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

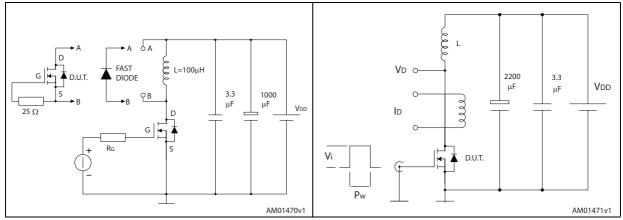
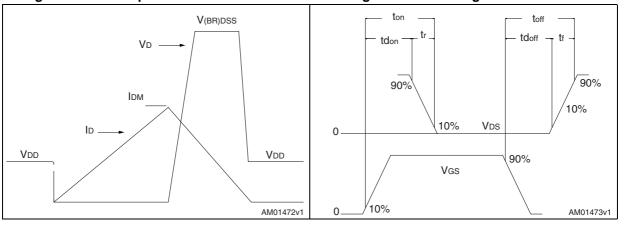


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.

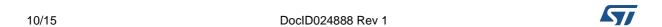
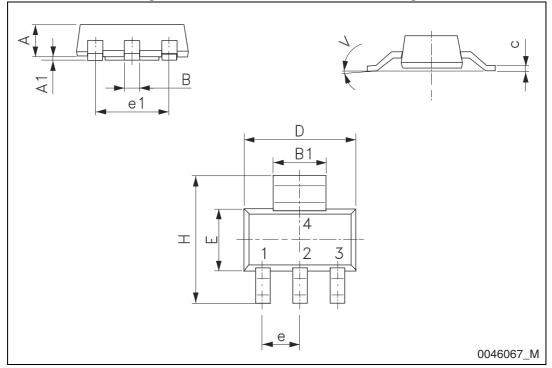


Table 9. SOT-223 mechanical data

Dim.		mm	
Dim.	Min.	Тур.	Max.
А			1.80
A1	0.02		0.1
В	0.60	0.70	0.85
B1	2.90	3.00	3.15
С	0.24	0.26	0.35
D	6.30	6.50	6.70
е		2.30	
e1		4.60	
E	3.30	3.50	3.70
Н	6.70	7.00	7.30
V			10°

Figure 21. SOT-223 mechanical data drawing

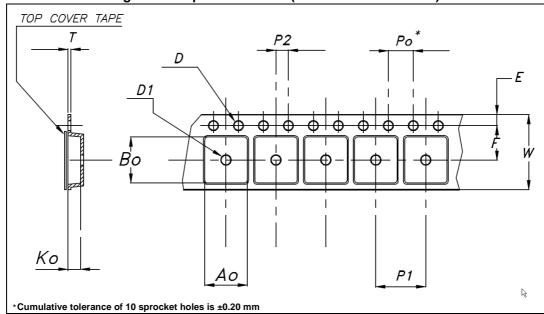


## 5 Packaging mechanical data

Table 10. SOT-223 tape and reel mechanical data

	Table 101 001 220 tape and 1001 moontained add							
		Таре	Reel					
Dim.		mm		mm		Dim.	mm	
Dilli.	Min.	Тур.	Max.	Dilli.	Min.	Max.		
A0	6.75	6.85	6.95	А		180		
В0	7.30	7.40	7.50	N	60			
K0	1.80	1.90	2.00	W1		12.4		
F	5.40	5.50	5.60	W2		18.4		
E	1.65	1.75	1.85	W3	11.9	15.4		
W	11.7	12	12.3					
P2	1.90	2	2.10	Base qu	antity pcs	1000		
P0	3.90	4	4.10	Bulk qua	antity pcs	1000		
P1	7.90	8	8.10					
Т	0.25	0.30	0.35					
Dφ	1.50	1.55	1.60					
D1¢	1.50	1.60	1.70					

Figure 22. Tape for SOT-223 (dimensions are in mm)



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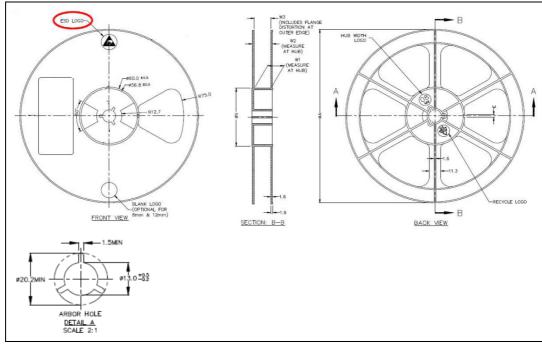


Figure 23. Reel for TO-223 (dimensions are in mm)



Revision history STN3N45K3

# 6 Revision history

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**Table 11. Document revision history** 

Date	Revision	Changes
25-Jun-2013	1	First release. Part number previously included in datasheet DocID17206

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